WSJ2M60R065DTL

Super-Junction Power MOSFET

Rev.01 - 09 April 2025 Product data sheet

1. General description

WSJ2M60R065DTL is a high voltage N-channel MOSFET in TOLL package, which utilizes the advanced super-junction technology to provide superior FOM $R_{DS(on)}$*Qg among silicon based MOSFETs. It is particularly suitable for applications require extreme high efficiency and power density.

2. Features and benefits

- Superior FOM $R_{DS(on)}$ * Q_g
- Extremely low switching loss
- Integrated ultrafast body diode
- 100% avalanche tested

3. Applications

- Telecom and server power supplies
- LED lighting
- Adapter
- Solar
- UPS

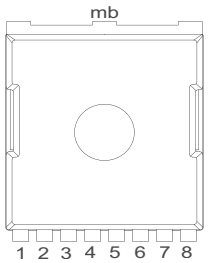
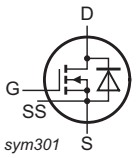
4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Notes	Values			Unit
Absolute maximum rating							
V_{DS}	drain-source voltage			600			V
V_{GS}	gate-source voltage	static		±20			V
V_{GS}	gate-source voltage	dynamic AC (f > 1 HZ)		±30			V
I_D	continuous drain current	T_C = 25 °C		42			A
P_{tot}	power dissipation	T_C = 25 °C		265			W
T_j	junction temperature			-55 to 150			°C
Symbol	**Parameter**	**Conditions**	**Notes**	**Min**	**Typ**	**Max**	**Unit**
Static characteristics							
$R_{DS(on)}$	drain-source on-state resistance	V_{GS} = 10 V, I_D = 21 A		-	56	65	mΩ
Dynamic characteristics							
$Q_{G(tot)}$	total gate charge	I_D = 21 A; V_{DS} = 400 V; V_{GS} = 10 V		-	82	-	nC
E_{OSS}	coss stored erergy	V_{GS} = 0 V; V_{DS} = 0 to 400 V		-	9.4	-	μJ

5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		
2	SS	source sense		
3-8	S	source		
mb	D	mounting base; connected to drain		

6. Ordering information

Table 3. Ordering information

Type number	Package name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date
WSJ2M60R065DTL	TOLL	WSJ2M60R065DTLJ	Reel	1800	TOLLN	12-Jan-2024

7. Marking

Table 4. Marking codes

Type number	Marking codes
WSJ2M60R065DTL	WSJ2M 60R065DTL

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8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Notes	Values	Unit
V_{DS}	drain-source voltage			600	V
V_{GS}	gate-source voltage	static		±20	V
V_{GS}	gate-source voltage	dynamic AC (f > 1 HZ)		±30	V
I_D	continuous drain current	T_C = 25 °C		42	A
		T_C = 100 °C		27	A
I_{DM}	pulsed drain current	T_C = 25 °C		168	A
P_{tot}	power dissipation	T_C = 25 °C		265	W
E_{AS}	single pulse drain−to-source avalanche	I_{AS} = 8.4 A; R_{GS} = 25 Ω; V_{DD} = 50 V; T_j = 25 °C		352	mJ
E_{AR}	repetitive avalanche energy	I_{AS} = 8.4 A; R_{GS} = 25 Ω; V_{DD} = 50 V; T_j = 25 °C		1.98	mJ
I_{AS}	avalanche current, single pulse			8.4	A
dv/dt	MOSFET dv/dt ruggedness			120	V/ns
dv/dt	reverse diode dv/dt			60	V/ns
dI_F/dt	maximum diode commutation speed			1000	A/µs
T_{stg}	storage temperature			-55 to 150	°C
T_j	junction temperature			-55 to 150	°C

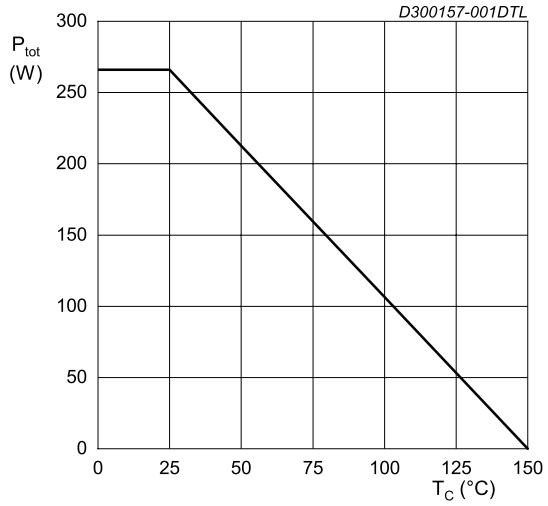

Fig. 1. Normalized total power dissipation as a function of case temperature

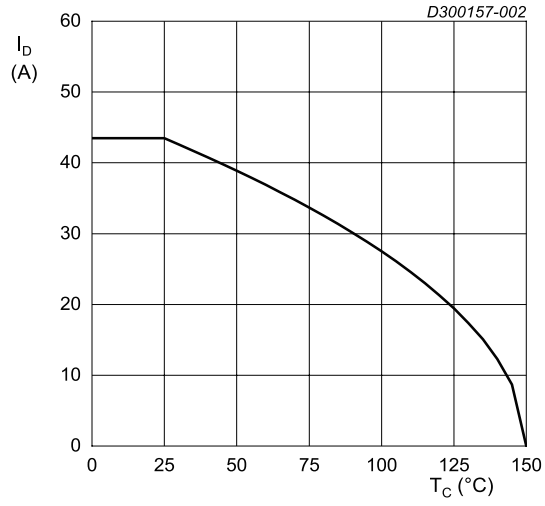

Fig. 2. Continuous Drain Current as a function of case temperature

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9. Thermal & Mechanical characteristics

Table 6. Thermal & Mechanical characteristics

Symbol	Parameter	Conditions	Notes	Min	Typ	Max	Unit
$R_{th(j-c)}$	thermal resistance from junction to case			-	0.33	0.47	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air		-	45	-	K/W

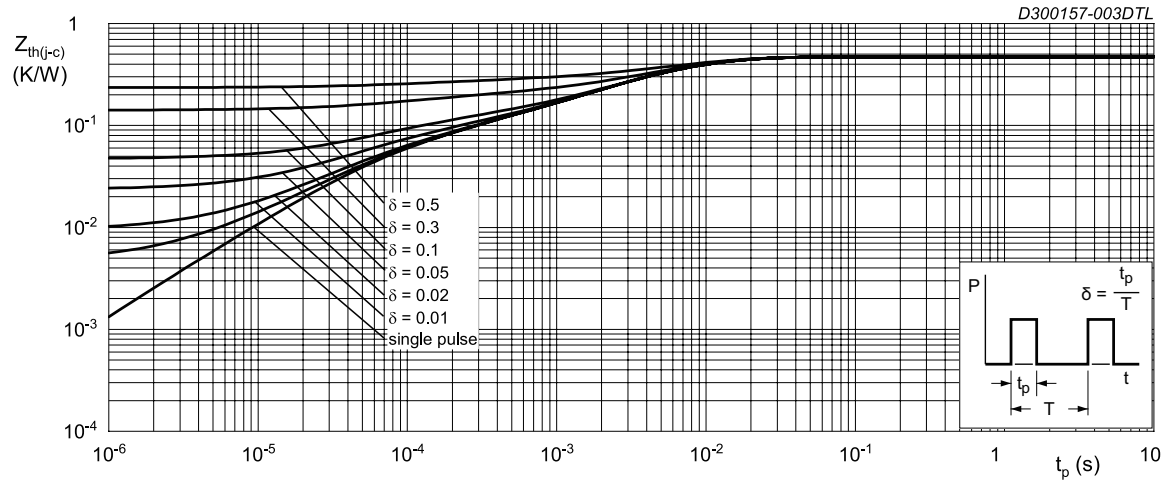

Fig. 3. Transient thermal impedance from junction to case as a function of pulse duration

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10. Characteristics

Table 7. Characteristics

T_j = 25 °C unless otherwise noted

Symbol	Parameter	Conditions	Notes	Min	Typ	Max	Unit
Static characteristics							
$V_{(BR)DSS}$	drain-source breakdown voltage	I_D = 1 mA; V_{GS} = 0 V		600	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	I_D = 250 µA; V_{DS} = V_{GS}		3.0	-	5.0	V
I_{DSS}	drain leakage current	V_{DS} = 600 V; V_{GS} = 0 V		-	-	10	µA
		V_{DS} = 600 V; V_{GS} = 0 V; T_j = 125 °C		-	200	-	µA
I_{GSS}	gate leakage current	V_{GS} = ±20 V; V_{DS} = 0 V		-	-	±100	nA
$R_{DS(on)}$	drain-source on-state resistance	V_{GS} = 10 V; I_D = 21 A		-	56	65	mΩ
R_G	gate resistance	f = 1 MHz		-	1.7	-	Ω
Dynamic characteristics							
$Q_{G(tot)}$	total gate charge	I_D = 21 A; V_{DS} = 400 V; V_{GS} = 10 V		-	82	-	nC
Q_{GS}	gate-source charge			-	28	-	nC
Q_{GD}	gate-drain charge			-	34	-	nC
C_{iss}	input capacitance	V_{DS} = 400 V; V_{GS} = 0 V; f = 1 MHz		-	3368	-	pF
C_{oss}	output capacitance			-	61	-	pF
C_{rss}	reverse transfer capacitance			-	2.0	-	pF
$C_{o(er)}$	effective output capacitance, energy related	V_{GS} = 0 V; V_{DS} = 0 to 400 V		-	117	-	pF
$C_{o(tr)}$	effective output capacitance, time related			-	1021	-	pF
$t_{d(on)}$	turn-on delay time	V_{DS} = 400 V; V_{GS} = 10 V; R_G = 5 Ω; I_D = 21 A		-	62	-	ns
t_r	rise time			-	12	-	ns
$t_{d(off)}$	turn-off delay time			-	73	-	ns
t_f	fall time			-	3.5	-	ns
Source-drain diode							
V_{SD}	source-drain voltage	V_{GS} = 0 V; I_S = 21 A		-	1.0	1.2	V
I_S	body-diode continuous current	T_C = 25 °C		-	-	42	A
t_{rr}	reverse recovery time	V_R = 400 V; I_F = 21 A; dI_F/dt = 100 A/µs		-	123	-	ns
Q_{rr}	reverse recovered charge			-	0.7	-	µC
I_{rrm}	reverse recovery current			-	11	-	A

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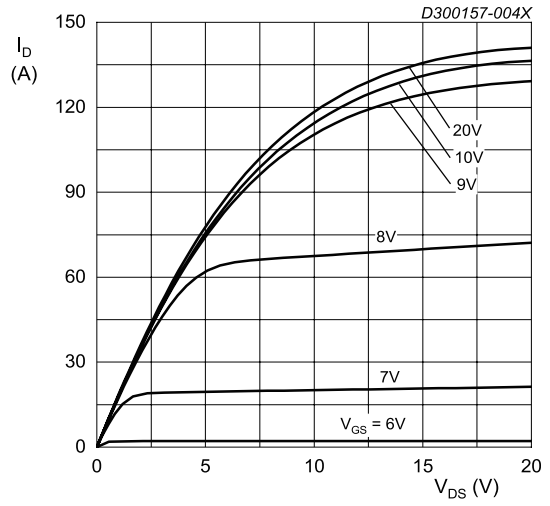
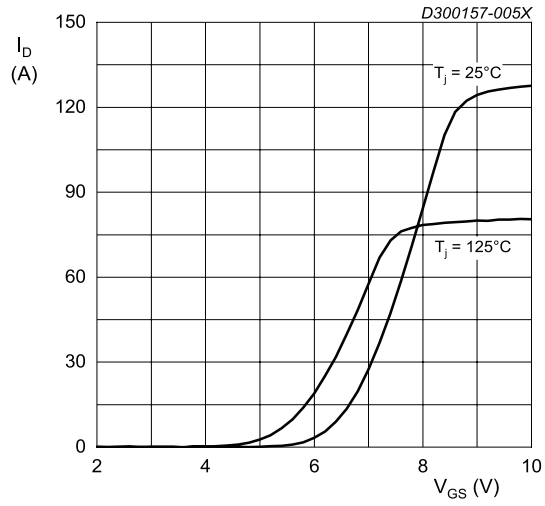
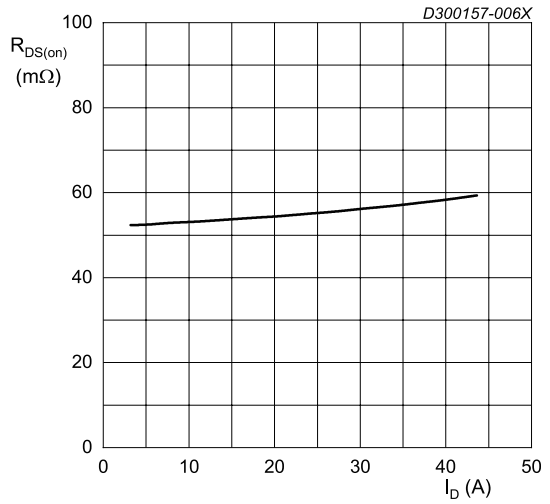


Fig. 4. Drain current as a function of drain-source voltage; typical values



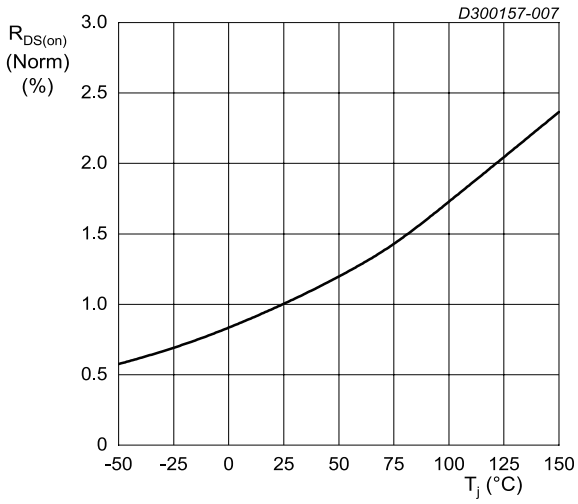
V_{DS} = 20 V

Fig. 5. Drain current as a function of gate-source voltage; typical values



V_{GS} = 10 V

Fig. 6. Drain-source on-state resistance as a function of drain current; typical values



V_{GS} = 10 V; I_D = 21 A

Fig. 7. Normalized drain-source on-state resistance as a function of junction temperature

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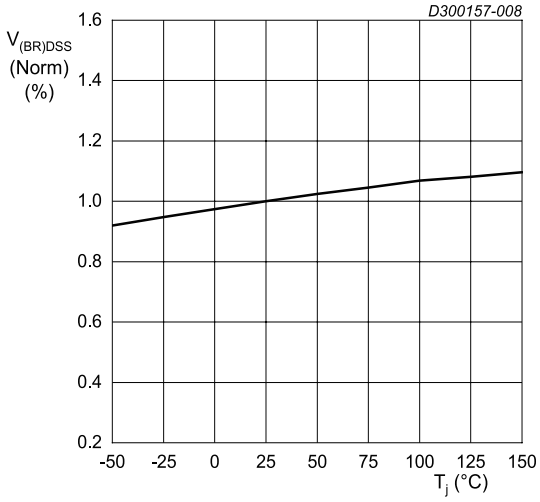
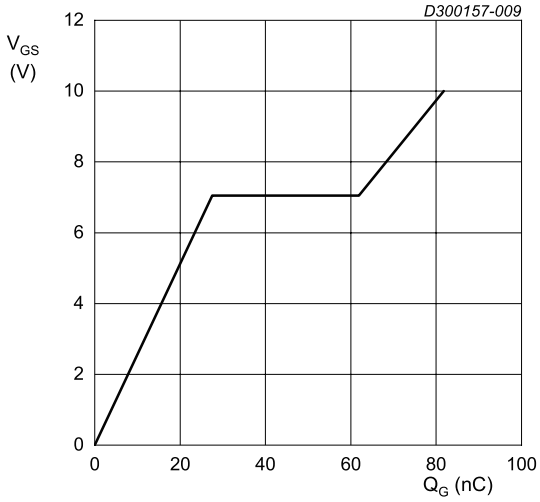


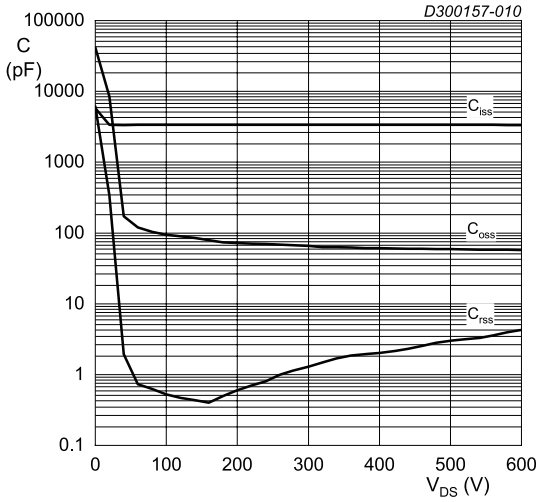
I_D = 5 mA

Fig. 8. Normalized drain-source breakdown voltage as a function of junction temperature



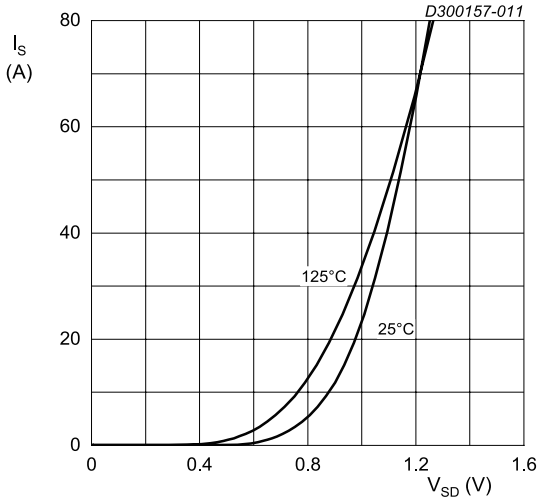
I_D = 21 A; V_{DS} = 400 V

Fig. 9. Gate-source voltage as a function of gate charge; typical values



V_{GS} = 0 V; f = 1 MHz

Fig 10. Capacitances as a function of drain-source voltage; typical values



V_{GS} = 0 V

Fig 11. Source current as a function of source-drain voltage; typical values

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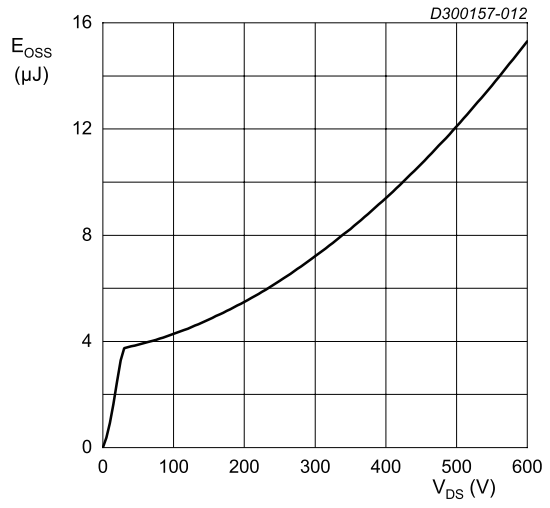
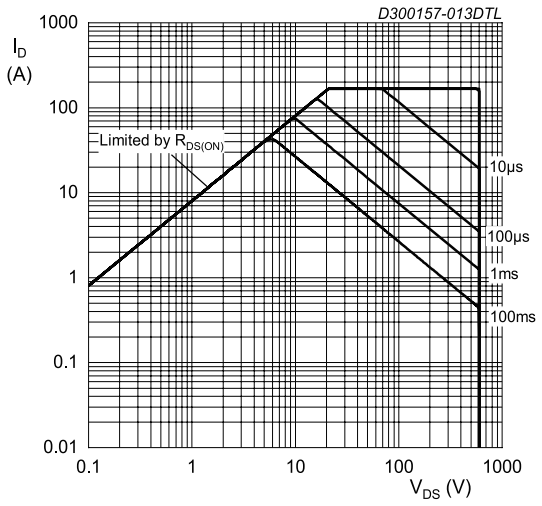


Fig. 12. Output capacitance stored energy as a function of drain-source voltage



T_C = 25 °C

Fig. 13. Safe operating area

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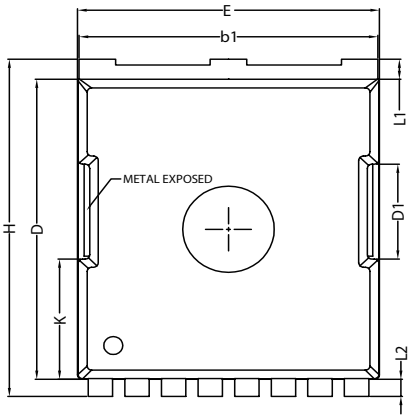
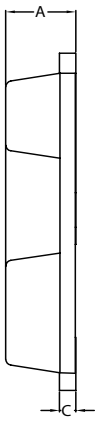
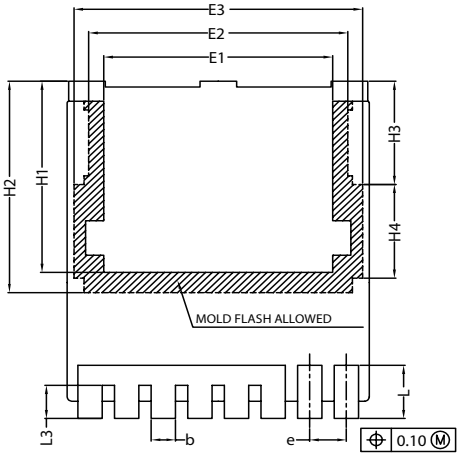
11. Package outline



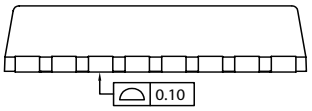
TOP VIEW



SIDE VIEW



BOTTOM VIEW



SIDE VIEW

(UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	NOM	MAX
A	2.20	2.30	2.40
b	0.70	0.80	0.90
b1	9.70	9.80	9.90
c	0.40	0.50	0.60
D	10.28	10.43	10.58
D1	3.15	3.30	3.45
E	9.70	9.90	10.10
E1	7.35	7.50	7.65
E2	8.35	8.50	8.65
E3	9.31	9.46	9.61
e	1.10	1.20	1.30
H	11.48	11.73	11.88
H1	6.55	6.65	6.75
H2	7.20	7.35	7.50
H3	3.44	3.59	3.74
H4	3.11	3.26	3.41
K	4.03	4.18	4.33
L	1.60	1.85	2.10
L1	0.55	0.70	0.85
L2	0.45	0.60	0.75
L3	1.00	1.15	1.30

Note:
All dimensions do not include mold flash or protrusion.

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Document status [1][2]	Product status [3]	Definition
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Product [short] data sheet	Production	This document contains the product specification.

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